



SANYO Semiconductors

DATA SHEET

An ON Semiconductor Company

N-Channel Silicon MOSFET

ATP202 — General-Purpose Switching Device Applications

Features

- Low ON-resistance
- 4.5V drive
- Halogen free compliance
- Large current
- Slim package
- Protection diode in

Specifications

Absolute Maximum Ratings at $T_a=25^\circ\text{C}$

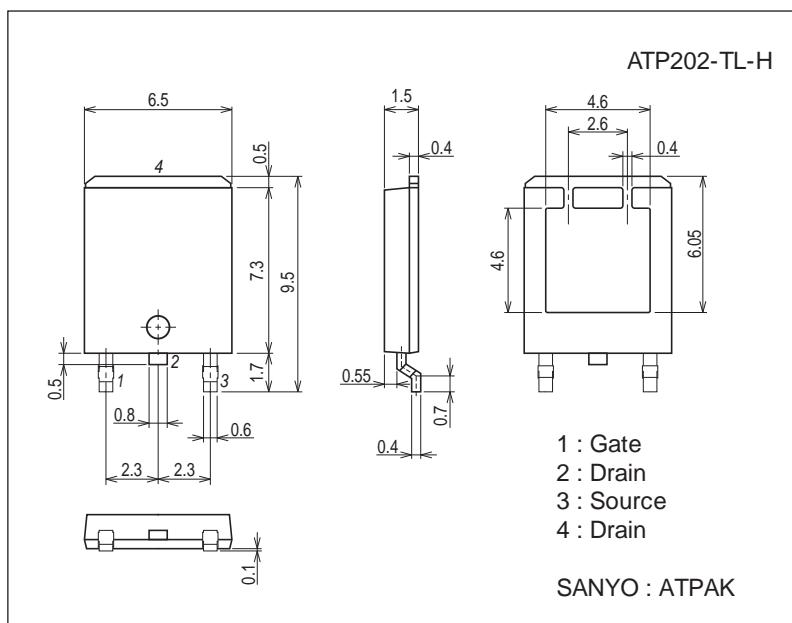
Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V_{DSS}		30	V
Gate-to-Source Voltage	V_{GSS}		± 20	V
Drain Current (DC)	I_D		50	A
Drain Current ($P_W \leq 10\mu\text{s}$)	I_{DP}	$P_W \leq 10\mu\text{s}$, duty cycle $\leq 1\%$	150	A
Allowable Power Dissipation	P_D	$T_c=25^\circ\text{C}$	40	W
Channel Temperature	T_{ch}		150	$^\circ\text{C}$
Storage Temperature	T_{stg}		-55 to +150	$^\circ\text{C}$
Avalanche Energy (Single Pulse) *1	E_{AS}		45	mJ
Avalanche Current *2	I_{AV}		25	A

Note : *1 $V_{DD}=10\text{V}$, $L=100\mu\text{H}$, $I_{AV}=25\text{A}$ *2 $L \leq 100\mu\text{H}$, Single pulse

Package Dimensions

unit : mm (typ)

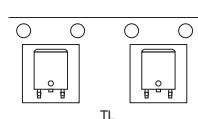
7057-001



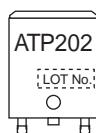
Product & Package Information

- Package : ATPAK
- JEITA, JEDEC : -
- Minimum Packing Quantity : 3,000 pcs./reel

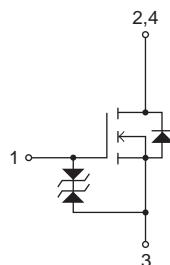
Packing Type: TL



Marking



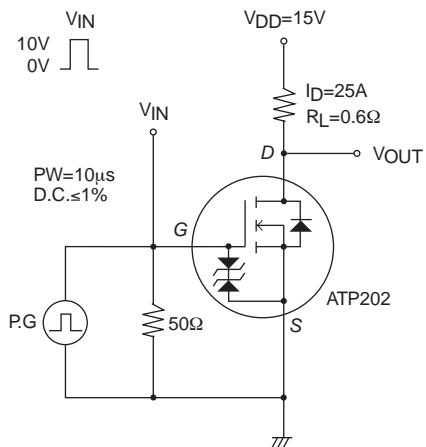
Electrical Connection



Electrical Characteristics at $T_a=25^\circ\text{C}$

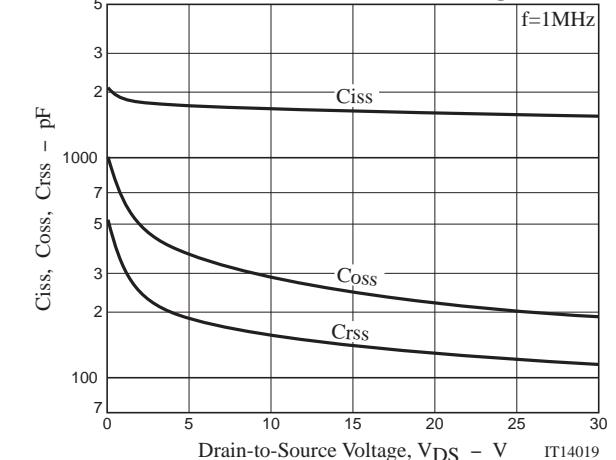
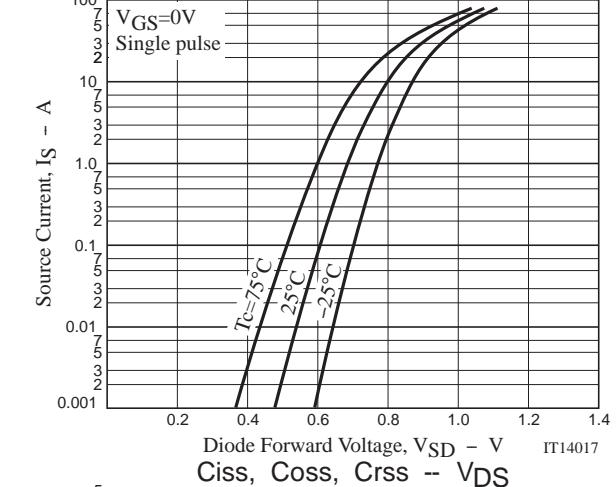
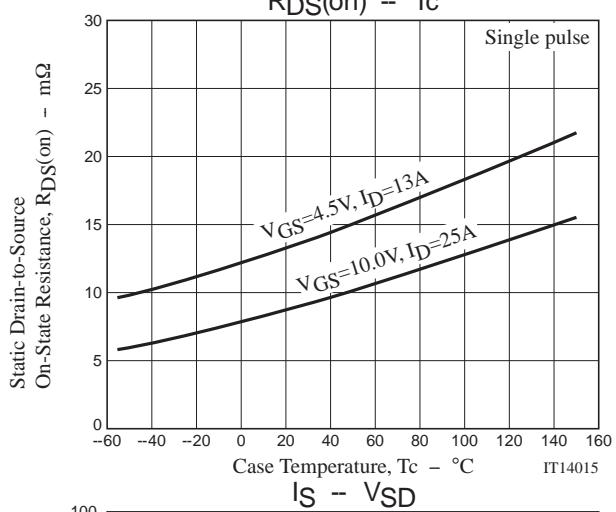
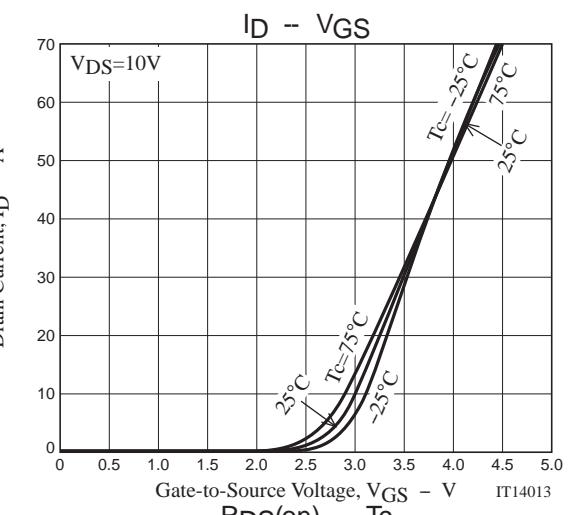
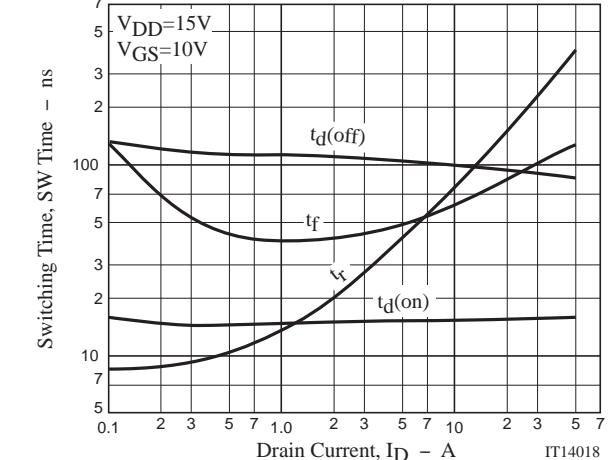
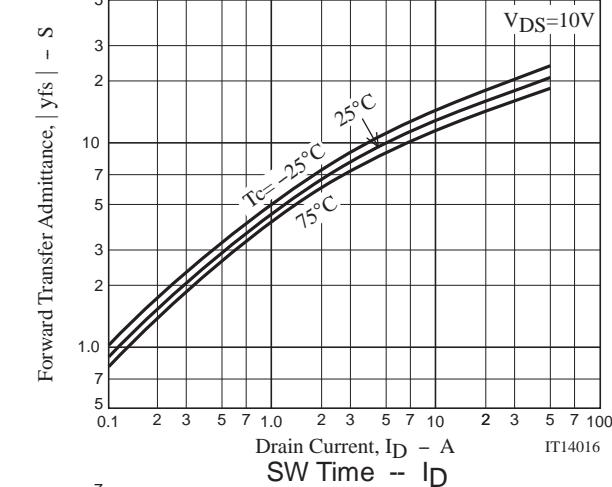
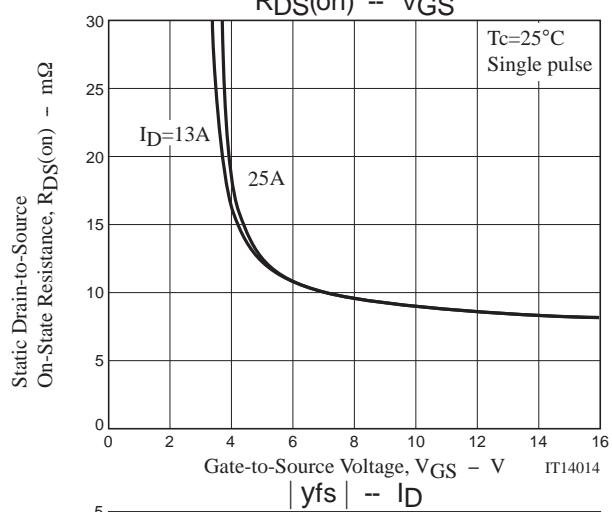
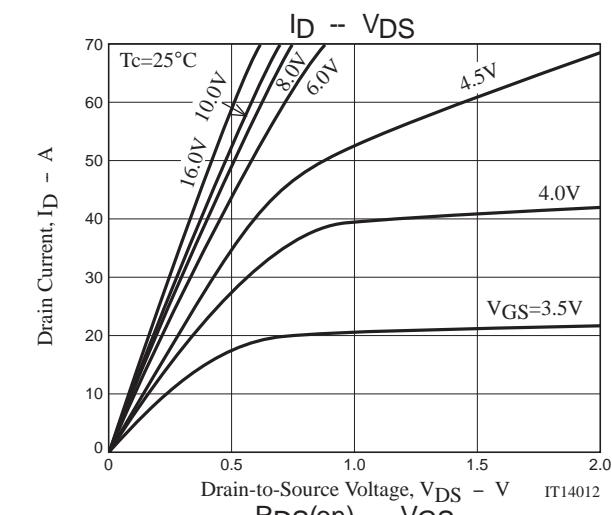
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Drain-to-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D=1\text{mA}, V_{GS}=0\text{V}$	30			V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$			1	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 16\text{V}, V_{DS}=0\text{V}$			± 10	μA
Cutoff Voltage	$V_{GS(\text{off})}$	$V_{DS}=10\text{V}, I_D=1\text{mA}$	1.2		2.6	V
Forward Transfer Admittance	$ y_{fs} $	$V_{DS}=10\text{V}, I_D=25\text{A}$	10	17		S
Static Drain-to-Source On-State Resistance	$R_{DS(\text{on})1}$	$I_D=25\text{A}, V_{GS}=10\text{V}$		9	12	$\text{m}\Omega$
	$R_{DS(\text{on})2}$	$I_D=13\text{A}, V_{GS}=4.5\text{V}$		14	20	$\text{m}\Omega$
Input Capacitance	C_{iss}	$V_{DS}=10\text{V}, f=1\text{MHz}$		1650		pF
Output Capacitance	C_{oss}			285		pF
Reverse Transfer Capacitance	C_{rss}			160		pF
Turn-ON Delay Time	$t_{\text{d(on)}}$			16		ns
Rise Time	t_r	See specified Test Circuit.		185		ns
Turn-OFF Delay Time	$t_{\text{d(off)}}$			93		ns
Fall Time	t_f			93		ns
Total Gate Charge	Q_g			27		nC
Gate-to-Source Charge	Q_{gs}	$V_{DS}=15\text{V}, V_{GS}=10\text{V}, I_D=50\text{A}$		7.5		nC
Gate-to-Drain "Miller" Charge	Q_{gd}			4		nC
Diode Forward Voltage	V_{SD}			0.97	1.2	V

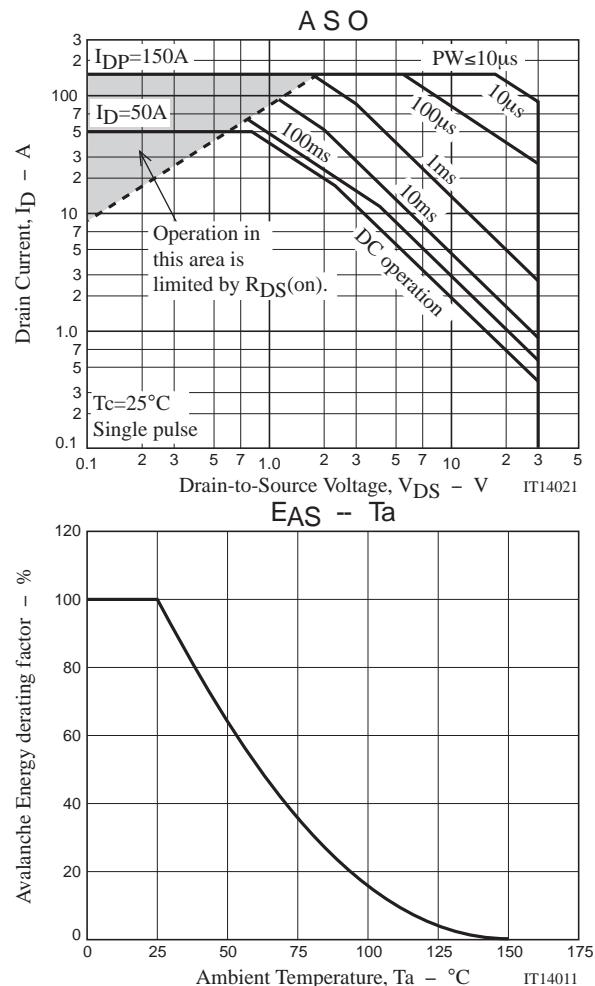
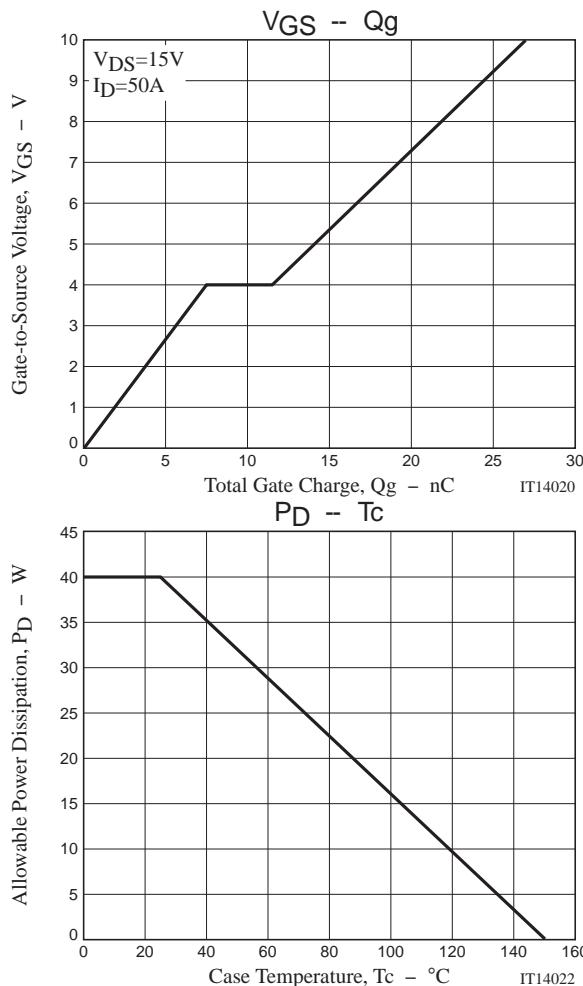
Switching Time Test Circuit



Ordering Information

Device	Package	Shipping	memo
ATP202-TL-H	ATPAK	3,000pcs./reel	Pb Free and Halogen Free



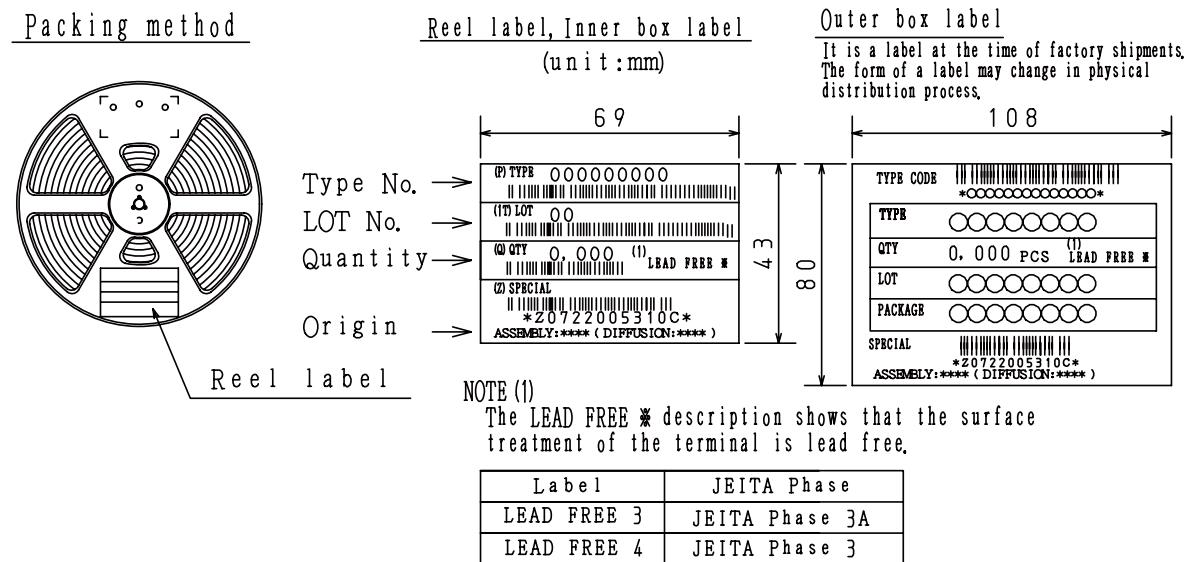


Taping Specification

ATP202-TL-H

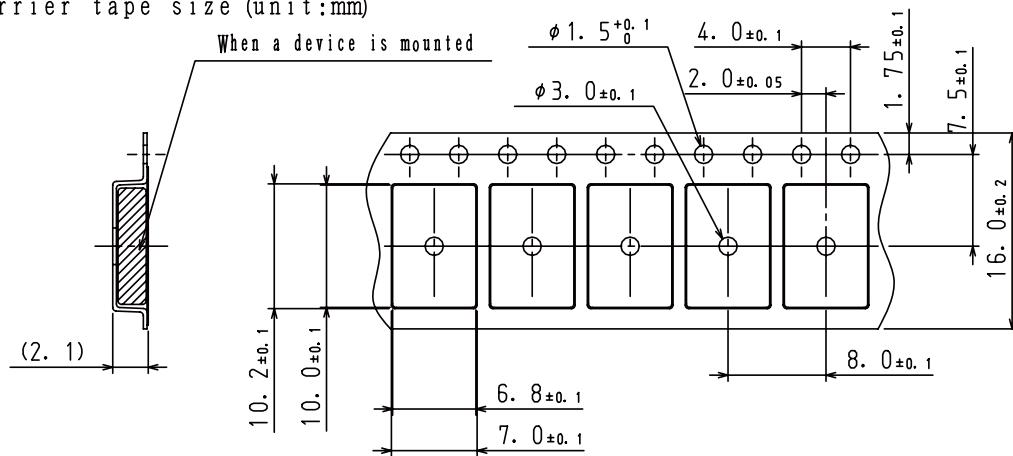
1. Packing Format (TL)

Package Name	Carrier Tape Type	Maximum Number of devices contained (pcs)			Packing format	
		Reel	Inner box	Outer box	INNER BOX SD-C-18	OUTER BOX SD-A-18
ATPAK	ATP	3,000	3,000	15,000	1 reels contained Dimensions:mm (external) 340×340×28	5 inner boxes contained Dimensions:mm (external) 355×355×165

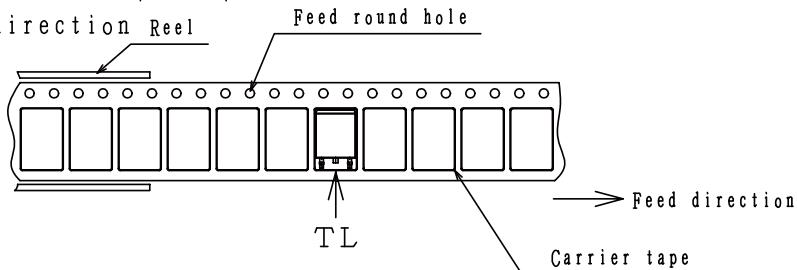


2. Taping configuration

2-1. Carrier tape size (unit:mm)



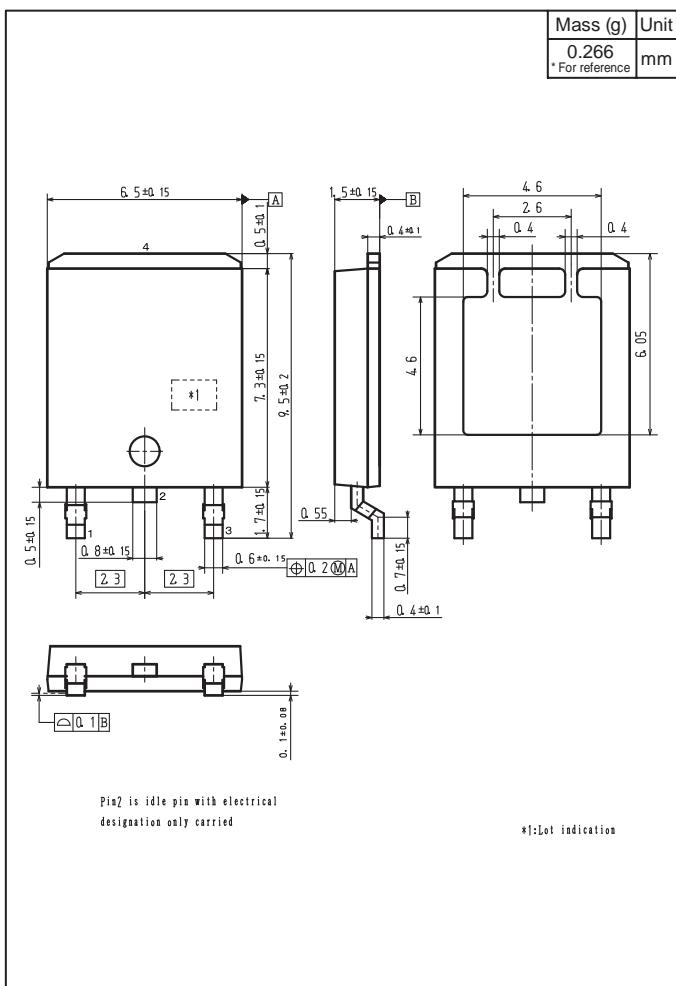
2-2. Device placement direction Reel



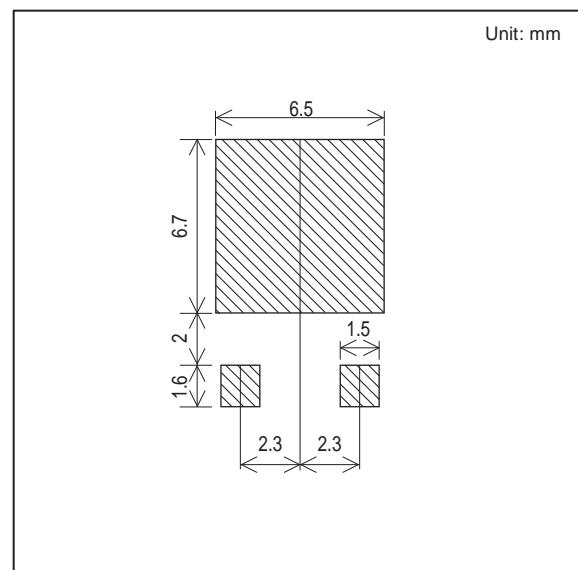
The one electrode terminals on feed hole side....TL

Outline Drawing

ATP202-TL-H



Land Pattern Example



Note on usage : Since the ATP202 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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